

## FEATURES

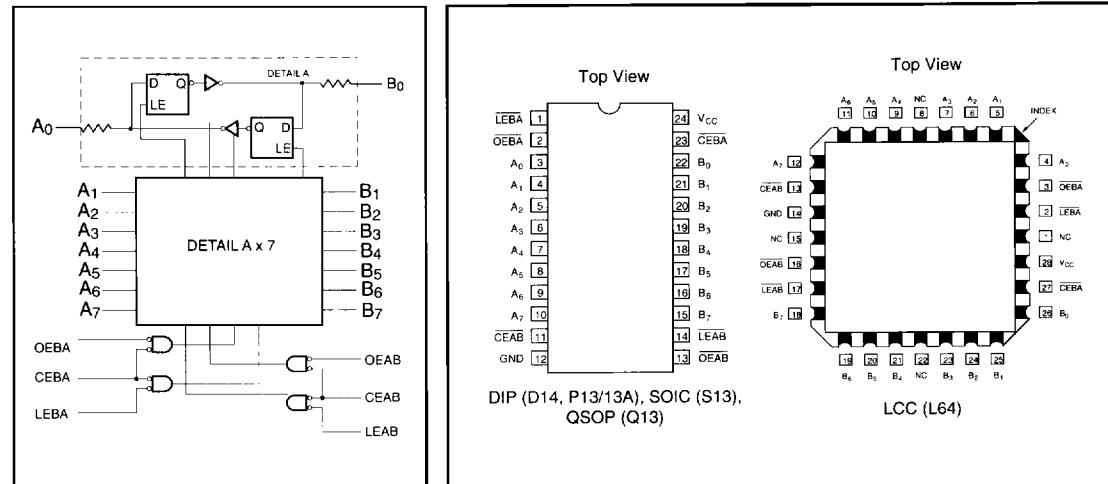
- Function and Pinout Compatible with the FCT and F Logic
- FCT-C speed at 5.3ns max. (Com'l)  
FCT-A speed at 6.5ns max. (Com'l)
- R25Ω output series resistors to reduce transmission line reflection noise
- Reduced  $V_{OH}$  (typically = 3.3V) versions of Equivalent FCT functions
- Edge-rate Control Circuitry for Significantly Improved Noise Characteristics
- Power-off disable feature
- Matched Rise and Fall times
- Fully Compatible with TTL Input and Output Logic Levels
- 12 mA Sink Current (Com'l), 12 mA (Mil)  
15 mA Source Current (Com'l), 12 mA (Mil)
- Separate Controls for Data Flow in Each Direction
- Back to Back Latches for Storage

## DESCRIPTION

The 'FCT2543T Octal Registered Transceiver contains two sets of eight D-type latches. Separate Latch Enable (LEAB, LEBA) and Output Enable (OEAB, OEBA) controls permit each latch set to have independent control of inputting and outputting in either direction of data flow. For data flow from A to B, for example, the A-to-B Enable (CEAB) input must be LOW to enter data from A0-A7 or to take data from B0-B7, as indicated in the truth table. With CEAB LOW, a LOW signal on the A-to-B Latch Enable (LEAB) input makes the A-to-B latches transpar-

ent; a subsequent LOW-to-HIGH transition of the LEAB signal puts the A latches in storage mode and their output no longer change with the A inputs. With CEAB and OEAB both LOW, the 3-state B output buffers are active and reflect data present at the output of the A latches. Control of data from B to A is similar, but uses CEAB, LEAB and OEAB inputs. On-chip termination resistors have been added to the outputs to reduce system noise caused by reflections. The 'FCT2543T can be used to replace the 'FCT543T to reduce noise in an existing design.

## FUNCTIONAL BLOCK DIAGRAM      PIN CONFIGURATIONS



## PIN DESCRIPTIONS

Pin Name	Description
OEAB	A-to-B Output Enable Input (Active LOW)
OEBA	B-to-A Output Enable Input (Active LOW)
CEAB	A-to-B Enable Input (Active LOW)
CEBA	B-to-A Enable Input (Active LOW)
LEAB	A-to-B Latch Enable Input (Active LOW)
LEBA	B-to-A Latch Enable Input (Active LOW)
A <sub>0</sub> -A <sub>7</sub>	A-to-B Data Inputs or B-to-A 3-State Outputs
B <sub>0</sub> -B <sub>7</sub>	B-to-A Data Inputs or A-to-B 3-State Outputs

## ABSOLUTE MAXIMUM RATINGS<sup>1,2</sup>

Sym	Parameter	Value	Unit
T <sub>STG</sub>	Storage Temperature	-65 to +150	°C
T <sub>A</sub>	Ambient Temperature Under Bias	-65 to +135	°C
V <sub>CC</sub>	V <sub>CC</sub> Potential to Ground	-0.5 to +7.0	V
P <sub>T</sub>	Power Dissipation	0.5	W
I <sub>OUTPUT</sub>	Current Applied to Output	120	mA
V <sub>IN</sub>	Input Voltage	-0.5 to +7.0	V
V <sub>OUT</sub>	Voltage Applied to Output	-0.5 to +7.0	V

## RECOMMENDED OPERATING CONDITIONS

Free Air Ambient Temperature	Min	Max
Military	-55°C	+125°C
Commercial	0°C	+70°C

Supply Voltage (V <sub>CC</sub> )	Min	Max
Military	+4.5V	+5.5V
Commercial	+4.75V	+5.25V

## DC ELECTRICAL CHARACTERISTICS (Over recommended operating conditions)

Symbol	Parameter		Min	Typ <sup>3</sup>	Max	Units	V <sub>CC</sub>	Conditions
V <sub>IH</sub>	Input HIGH Voltage		2.0			V		
V <sub>IL</sub>	Input LOW Voltage				0.8	V		
V <sub>H</sub>	Hysteresis <sup>5</sup>			0.2		V		All inputs
V <sub>IK</sub>	Input Clamp Diode Voltage			-0.7	-1.2	V	MIN	I <sub>IN</sub> = -18mA
V <sub>OH</sub>	Output HIGH Voltage	Military Commercial	2.4 2.4	3.3 3.3		V	MIN MIN	I <sub>OH</sub> = -12mA I <sub>OH</sub> = -15mA
V <sub>OL</sub>	Output LOW Voltage	Military Commercial		0.3 0.3	0.5 0.5	V	MIN MIN	I <sub>OL</sub> = 12mA I <sub>OL</sub> = 12mA
R <sub>OUT</sub>	Output Resistance	Military Commercial	20	25 25	40	Ω	MIN MIN	I <sub>OL</sub> = 12mA I <sub>OL</sub> = 12mA
I <sub>IH</sub>	Input HIGH Current				20	μA	MAX	V <sub>IN</sub> = V <sub>CC</sub>
I <sub>IH</sub>	Input HIGH Current	Except I/O Pins			5	μA	MAX	V <sub>IN</sub> = 2.7V
		I/O Pins			15	μA	MAX	V <sub>IN</sub> = 2.7V
I <sub>IL</sub>	Input LOW Current	Except I/O Pins			-5	μA	MAX	V <sub>IN</sub> = 0.5V
		I/O Pins			-15	μA	MAX	V <sub>IN</sub> = 0.5V
I <sub>OZH</sub>	Off State I <sub>OUT</sub> HIGH-Level Output Current				15	μA	MAX	V <sub>OUT</sub> = 2.7V
I <sub>OZL</sub>	Off State I <sub>OUT</sub> LOW-Level Output Current				-15	μA	MAX	V <sub>OUT</sub> = 0.5V
I <sub>OS</sub>	Output Short Circuit Current <sup>4</sup>		-60	-120	-225	mA	MAX	V <sub>OUT</sub> = 0.0V
I <sub>OFF</sub>	Power-off Disable				100	μA	0V	V <sub>OUT</sub> = 4.5V
C <sub>IN</sub>	Input Capacitance <sup>5</sup>			5	10	pF	MAX	All inputs
C <sub>I/O</sub>	I/O Capacitance <sup>5</sup>			9	12	pF	MAX	All outputs
I <sub>CC</sub>	Quiescent Power Supply Current			0.2	1.5	mA	MAX	V <sub>IN</sub> ≤ 0.2V, V <sub>IN</sub> ≥ V <sub>CC</sub> - 0.2V

### Notes:

- Operation beyond the limits set forth in the above table may impair the useful life of the device. Unless otherwise noted, these limits are over the operating free-air temperature range.
- Unused inputs must always be connected to an appropriate logic voltage level, preferably either V<sub>CC</sub> or ground.
- Typical values are at V<sub>CC</sub> = 5.0V, T<sub>A</sub> = +25°C ambient.
- Not more than one output should be shorted at a time. Duration of short

should not exceed one second. The use of high speed test apparatus and/or sample and hold techniques are preferable in order to minimize internal chip heating and more accurately reflect operational values. Otherwise prolonged shorting of a high output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I<sub>OS</sub> tests should be performed last.

5. This parameter is guaranteed but not tested.

## DC CHARACTERISTICS (Over recommended operating conditions unless otherwise specified.)

Symbol	Parameter	Typ. <sup>6</sup>	Max.	Units	Conditions
$\Delta I_{CC}$	Quiescent Power Supply Current (TTL inputs)	0.5	2.0	mA	$V_{CC} = MAX, V_{IN} = 3.4V^7$ , $f_1 = 0$ , Outputs Open
$I_{CCD}$	Dynamic Power Supply Current <sup>8</sup>	0.15	0.25	mA/MHz	$V_{CC} = MAX$ , One Input Toggling, 50% Duty Cycle, $\overline{CEAB} + \overline{OEAB} = Low$ , Outputs Open, $CEAB = High$ , $V_{IN} \leq 0.2V$ or $V_{IN} \geq V_{CC} - 0.2V$
$I_C$	Total Power Supply Current <sup>10</sup>	1.7	4.0	mA	$V_{CC} = MAX, f_0 = 10MHz, \overline{CEAB} + \overline{OEAB} = Low$ 50% Duty Cycle, Outputs Open, $CEBA = High$ One Bit Toggling at $f_1 = 5MHz$ , $f_0 = \overline{LEAB} = 10MHz$ , $V_{IN} \leq 0.2V$ or $V_{IN} \geq V_{CC} - 0.2V$
		2.2	6.0	mA	$V_{CC} = MAX, f_0 = 10MHz, \overline{CEAB} + \overline{OEAB} = Low$ 50% Duty Cycle, Outputs Open, $CEBA = High$ One Bit Toggling at $f_1 = 5MHz$ , $f_0 = \overline{LEAB} = 10MHz$ , $V_{IN} = 3.4V$ or $V_{IN} = GND$
		7.0	12.8 <sup>9</sup>	mA	$V_{CC} = MAX, f_0 = 10MHz, \overline{CEAB} + \overline{OEAB} = Low$ 50% Duty Cycle, Outputs Open, $CEBA = High$ Eight Bits Toggling at $f_1 = 5MHz$ , $f_0 = \overline{LEAB} = 10MHz$ , $V_{IN} \leq 0.2V$ or $V_{IN} \geq V_{CC} - 0.2V$
		9.2	21.8 <sup>9</sup>	mA	$V_{CC} = MAX, f_0 = 10MHz, \overline{CEAB} + \overline{OEAB} = Low$ 50% Duty Cycle, Outputs Open, $CEBA = High$ Eight Bits Toggling at $f_1 = 5MHz$ , $f_0 = \overline{LEAB} = 10MHz$ , $V_{IN} = 3.4V$ or $V_{IN} = GND$

### Notes:

6. Typical values are at  $V_{CC} = 5.0V$ ,  $+25^\circ C$  ambient.
7. Per TTL driven input ( $V_{IN} = 3.4V$ ); all other inputs at  $V_{CC}$  or GND.
8. This parameter is not directly testable, but is derived for use in Total Power Supply calculations.
9. Values for these conditions are examples of the  $I_C$  formula. These limits are guaranteed but not tested.
10.  $I_C = I_{QUIESCENT} + I_{INPUTS} + I_{DYNAMIC}$   
 $I_C = I_{CC} + \Delta I_{CC} D_{H,T} N_T + I_{CCD} (f_0/2 + f_1 N_1)$   
 $I_{CC} = \text{Quiescent Current with CMOS input levels}$

$\Delta I_{CC}$  = Power Supply Current for a TTL High Input  
( $V_{IN} = 3.4V$ )

$D_H$  = Duty Cycle for TTL Inputs High

$N_T$  = Number of TTL Inputs at  $D_H$

$I_{CCD}$  = Dynamic Current Caused by an Input Transition Pair (HLH or LHL)

$f_0$  = Clock Frequency for Register Devices (Zero for Non-Register Devices)

$f_1$  = Input Frequency

$N_1$  = Number of Inputs at  $f_1$

All currents are in milliamps and all frequencies are in megahertz.

## TRUTH TABLE FOR A-TO-B (Symmetric with B-to-A)

Inputs			Latch Status	Outputs 'FCT2543T
CEAB	LEAB	OEAB	A-TO-B	B0-B7
H	-	-	Storing	High Z
-	H	-	Storing	-
-	-	H	-	High Z
L	L	L	Transparent	Current A Inputs
L	H	L	Storing	Previous A Inputs

\* = Before  $\overline{LEAB}$  LOW-to-HIGH Transition

H = HIGH Voltage Level

L = LOW Voltage Level

- = Don't Care or Irrelevant

A-to-B data flow shown: B-to-A flow control is the same, except using  $\overline{CEBA}$ ,  $\overline{LEBA}$ , and  $\overline{OEBA}$

## AC CHARACTERISTICS

Sym.	Parameter	'FCT2543T				'FCT2543AT				'FCT2543CT				Units	Fig. No.*		
		MIL		COM'L		MIL		COM'L		MIL		COM'L					
		Min. <sup>11</sup>	Max.														
$t_{PLH}$ $t_{PHL}$	Propagation Delay Transparent Mode $A_n$ to $B_n$ or $B_n$ to $A_n$	2.0	10.0	2.5	8.5	2.5	7.5	2.5	6.5	2.5	6.1	2.5	5.5	ns	1, 5		
$t_{PLH}$ $t_{PHL}$	Propagation Delay $\overline{LEBA}$ to $A_n$ $\overline{LEAB}$ to $B_n$	2.5	14.0	2.5	12.5	2.5	9.0	2.5	8.0	2.5	8.0	2.5	7.0	ns	1, 5		
$t_{PZH}$ $t_{PZL}$	Output Enable Time $\overline{OEBA}$ or $\overline{OEAB}$ to $A_n$ or $B_n$ $\overline{CEBA}$ or $\overline{CEAB}$ to $A_n$ or $B_n$	2.0	14.0	2.0	12.0	2.0	10.0	2.0	9.0	2.0	9.0	2.0	8.0	ns	1,7,8		
$t_{PHZ}$ $t_{PLZ}$	Output Disable Time $\overline{OEBA}$ or $\overline{OEAB}$ to $A_n$ or $B_n$ $\overline{CEBA}$ or $\overline{CEAB}$ to $A_n$ or $B_n$	2.0	13.0	2.0	9.0	2.0	8.5	2.0	7.5	2.0	7.5	2.0	6.5	ns	1,7,8		

## AC OPERATING REQUIREMENTS

Sym.	Parameter	'FCT2543T				'FCT2543AT				'FCT2543CT				Units	Fig. No.*		
		MIL		COM'L		MIL		COM'L		MIL		COM'L					
		Min. <sup>11</sup>	Max.														
$t_s$ (H) $t_s$ (L)	Set-up Time HIGH or LOW $A_n$ or $B_n$ to $\overline{LEBA}$ or $\overline{LEAB}$	3.0	—	3.0	—	2.0	—	2.0	—	2.0	—	2.0	—	ns	9		
$t_h$ (H) $t_h$ (L)	Hold Time HIGH or LOW $A_n$ or $B_n$ to $\overline{LEBA}$ or $\overline{LEAB}$	2.0	—	2.0	—	2.0	—	2.0	—	2.0	—	2.0	—	ns	9		
$t_w$	$\overline{LEBA}$ or $\overline{LEAB}$ Pulse Width LOW	5.0	—	5.0	—	5.0	—	5.0	—	5.0	—	5.0	—	ns	6		

### Note:

11. Minimum limits are guaranteed on Propagation Delays.

\*Refer to the 'Parameter Measurement Information' section of this book.

## ORDERING INFORMATION

